

Notice of References Cited

Application/Control No.

10/521,156

Applicant(s)/Patent Under
Reexamination
AMEMIYA ET AL.

Examiner

KEVIN Y. KIM

Art Unit

3714

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2001/0037315 A1	11-2001	Saliba et al.	705/70
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
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FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

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